

# **ZXTP19100CFF** 100V, SOT23F, PNP medium power transistor

## **Summary**

 $BV_{CEO} > -100V$ 

 $BV_{ECO} > -7V$ 

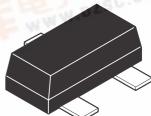
 $I_{C(cont)} = -2A$ 

V<sub>CE(sat)</sub> < 120mV @ 1A

 $R_{CE(sat)} = 95m\Omega$ 

 $P_{D} = 1.5W$ 

Complementary part number: ZXTN19100CFF



## **Description**

Packaged in the SOT23 outline this new low saturation 100V PNP transistor offers extremely low on state losses making it ideal for use in DC-DC circuits and various driving and power management functions.

### **Features**

- 2 amps continuous current
- Very low saturation voltages

## **Applications**

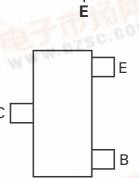
- · Emergency lighting circuits
- Motor driving (including DC fans)
- Solenoid, relay and actuator drivers
- DC-DC modules
- Backlight inverters
- Power switches
- MOSFET gate drivers

#### **Ordering information DEVICE** Reel size Tape width Quantity (inches) (mm) per reel ZXTP19100CFFTA 3000

# **Device marking**

1E1





Top view

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# **Absolute maximum ratings**

Parameter	Symbol	Limit	Unit
Collector-base voltage	V <sub>CBO</sub>	-110	V
Collector-emitter voltage (forward blocking)	V <sub>CEX</sub>	-110	V
Collector-emitter voltage	V <sub>CEO</sub>	-100	V
Emitter-collector voltage (reverse blocking)	V <sub>ECO</sub>	-7	V
Emitter-base voltage	V <sub>EBO</sub>	-7	V
Continuous collector current <sup>(c)</sup>	I <sub>C</sub>	-2	Α
Peak pulse current	I <sub>CM</sub>	-3	Α
Base current	I <sub>B</sub>	-1	Α
Power dissipation at T <sub>A</sub> =25°C <sup>(a)</sup> Linear derating factor	P <sub>D</sub>	0.84	W mW/°C
Power dissipation at T <sub>A</sub> =25°C <sup>(b)</sup> Linear derating factor	P <sub>D</sub>	1.34	W mW/°C
Power dissipation at T <sub>A</sub> =25°C <sup>(c)</sup> Linear derating factor	P <sub>D</sub>	1.5	W mW/°C
Power dissipation at T <sub>A</sub> =25°C <sup>(d)</sup> Linear derating factor	P <sub>D</sub>	2	W mW/°C
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to 150	°C

## Thermal resistance

Parameter	Symbol	Value	Unit
Junction to Ambient <sup>(a)</sup>	$R_{\theta JA}$	149.3	°C/W
Junction to Ambient <sup>(b)</sup>	$R_{\theta JA}$	93.4	°C/W
Junction to Ambient <sup>(c)</sup>	$R_{\theta JA}$	83.3	°C/W
Junction to Ambient <sup>(d)</sup>	$R_{\theta JA}$	60	°C/W
Junction to Case <sup>(e)</sup>	$R_{\theta JC}$	38	°C/W

### NOTES:

<sup>(</sup>a) For a device surface mounted on 15mm x 15mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

<sup>(</sup>b) Mounted on 25mm x 25mm x 1.6mm FR4 PCB with a high coverage of single sided 2 oz copper in still air conditions.

<sup>(</sup>c) Mounted on 50mm x 50mm x 1.6mm FR4 PCB with a high coverage of single sided 2 oz copper in still air conditions.

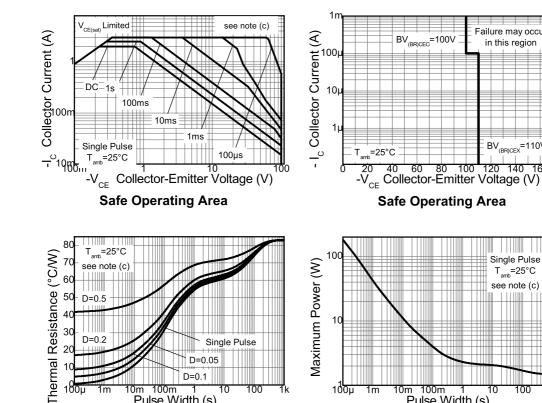
<sup>(</sup>d) As (c) above measured at t<5secs

<sup>(</sup>e) Junction to Case from Collector Tab.

Failure may occur

in this region

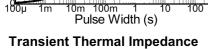
## Thermal characteristics

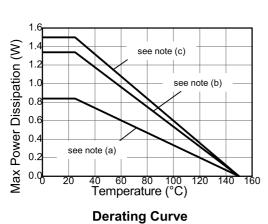


D=0.05

Maximum Power (W) T<sub>amb</sub>=25°C see note (c) 0m 100m 1 1 Pulse Width (s)

**Safe Operating Area** 





**Pulse Power Dissipation** 

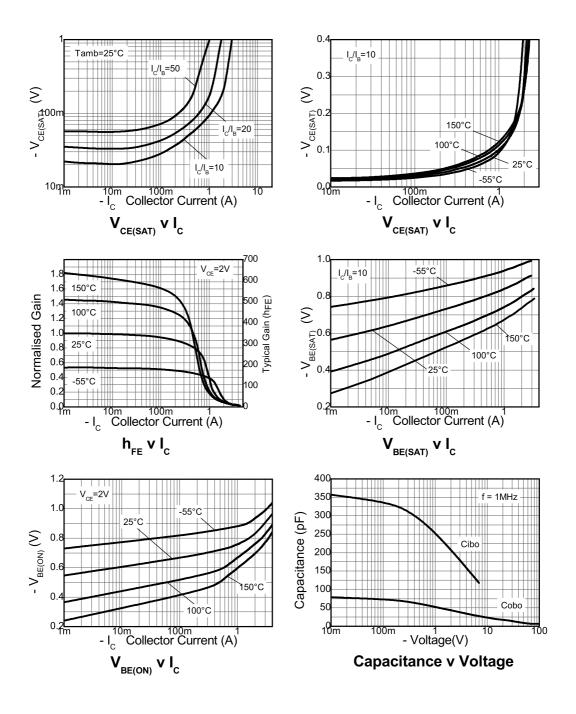
# Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated).

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-Base Breakdown Voltage	BV <sub>CBO</sub>	-110	-135		V	I <sub>C</sub> = -100μA
Collector-Emitter Breakdown Voltage (Base open)	BV <sub>CEX</sub>	-110	-135		V	$I_{C}$ = -100 $\mu$ A, $R_{BC}$ < 1k $\Omega$ or 0.25V > V <sub>BC</sub> > -0.25V
Collector-Emitter Breakdown Voltage (Base open)	BV <sub>CEO</sub>	-100	-135		V	I <sub>C</sub> = -10mA <sup>(*)</sup>
Emitter-Base Breakdown Voltage	BV <sub>EBO</sub>	-7	-8.3		V	I <sub>E</sub> = -100μA
Emitter-Collector Breakdown Voltage (Reverse Blocking)	BV <sub>ECX</sub>	-7	-8.3		V	$I_E = -100 \mu A$ , $R_{BC} < 1 \text{k6 or}$ 0.25V > $V_{BC}$ > -0.25V
Emitter-Collector Breakdown Voltage (Base open)	BV <sub>ECO</sub>	-7	-8.7		V	I <sub>E</sub> = -100μA
Collector-Base Cut-Off	I <sub>CBO</sub>		<-1	-50	nA	V <sub>CB</sub> = -110V
Current				-0.5	μΑ	$V_{CB} = -110V, T_{amb} = 100^{\circ}C$
Emitter-Base Cut-Off Current	I <sub>EBO</sub>		<-1	-50	nA	V <sub>EB</sub> = -5.6V
Collector-Emitter	V <sub>CE(sat)</sub>		-100	-130	mV	$I_C = -0.5A$ , $I_B = -20mA^{(*)}$
Saturation Voltage			-95	-120	mV	$I_C = -1A$ , $I_B = -100 \text{mA}^{(*)}$
			-175	-225	mV	$I_C = -1A$ , $I_B = -50 \text{mA}^{(*)}$
			-215	-275	mV	$I_C = -2A$ , $I_B = -200 \text{mA}^{(*)}$
Base-Emitter Saturation Voltage	V <sub>BE(sat)</sub>		-870	-950	mV	$I_C = -2A$ , $I_B = -200 \text{mA}^{(*)}$
Base-Emitter Turn-On Voltage	V <sub>BE(on)</sub>		-810	-900	mV	$I_C = -2A$ , $V_{CE} = -2V^{(*)}$
Static Forward Current	h <sub>FE</sub>	200	330	500		$I_C = -100 \text{mA}, V_{CE} = -2V^{(*)}$
Transfer Ratio		70	135			$I_C = -1A$ , $V_{CE} = -2V^{(*)}$
		20	30			$I_C = -2A$ , $V_{CE} = -2V^{(*)}$
Transition Frequency	f <sub>T</sub>		142		MHz	I <sub>C</sub> = -100mA, V <sub>CE</sub> = -10V f = 50MHz
Input Capacitance	C <sub>ibo</sub>		291	400	pF	V <sub>EB</sub> = -0.5V, f = 1MHz <sup>(*)</sup>
Output Capacitance	C <sub>obo</sub>		23.5		pF	V <sub>CB</sub> = -10V, f = 1MHz <sup>(*)</sup>
Delay Time	t <sub>d</sub>		24.7		ns	
Rise Time	t <sub>r</sub>		22.4		ns	$I_C = -500 \text{mA}, V_{CC} = -10 \text{V}$
Storage Time	t <sub>s</sub>		660		ns	$I_{B1} = -I_{B2} = -50 \text{mA}$
Fall Time	t <sub>f</sub>		107		ns	1

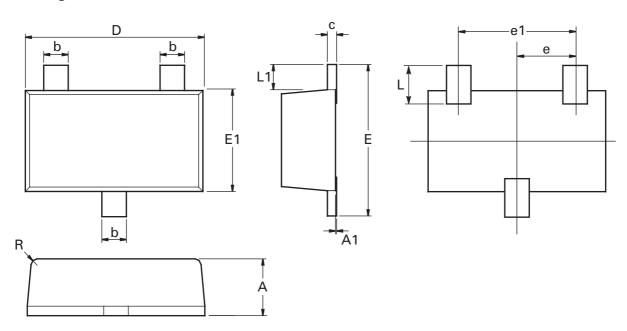
## NOTES:

(\*) Measured under pulsed conditions. Pulse width  $\leq 300 \, \mu s;$  duty cycle  $\leq 2\%.$ 

## **Typical characteristics**



# Package outline - SOT23F



Dim.	Millim	neters	Inc	Inches Dim. Millimeters Inche		Millimeters		hes	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.80	1.00	0.0315	0.0394	Е	2.30	2.50	0.0906	0.0984
A1	0.00	0.10	0.00	0.0043	E1	1.50	1.70	0.0590	0.0669
b	0.35	0.45	0.0153	0.0161	L	0.48	0.68	0.0189	0.0268
С	0.10	0.20	0.0043	0.0079	L1	0.30	0.50	0.0153	0.0161
D	2.80	3.00	0.1102	0.1181	R	0.05	0.15	0.0019	0.0059
е	0.95	ref	0.037	74 ref	0	0°	12°	0°	12°
e1	1.80	2.00	0.0709	0.0787	-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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### Zetex sales offices

Europe	Americas	Asia Pacific	Corporate Headquarters
Zetex GmbH Kustermann-park Balanstraße 59 D-81541 München Germany	Zetex Inc 700 Veterans Memorial Highway Hauppauge, NY 11788 USA	Zetex (Asia Ltd) 3701-04 Metroplaza Tower 1 Hing Fong Road, Kwai Fong Hong Kong	Zetex Semiconductors plc Zetex Technology Park, Chadderton Oldham, OL9 9LL United Kingdom
Telefon: (49) 89 45 49 49 0 Fax: (49) 89 45 49 49 49 europe.sales@zetex.com	Telephone: (1) 631 360 2222 Fax: (1) 631 360 8222 usa.sales@zetex.com	Telephone: (852) 26100 611 Fax: (852) 24250 494 asia.sales@zetex.com	Telephone: (44) 161 622 4444 Fax: (44) 161 622 4446 hq@zetex.com

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